

CMOS 8-STAGE STATIC SHIFT REGISTER

Check for Samples: CD4021B-Q1

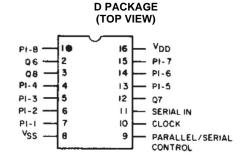
FEATURES

- Qualified for Automotive Applications
- Medium-Speed Operation: 12-MHz (Typ) Clock Rate at V_{DD} - V_{SS} = 10 V
- Fully Static Operation
- Eight Master-Slave Flip-Flops Plus Output Buffering and Control Gating
- 100% Tested for Quiescent Current at 20 V
- Maximum Input Current of 1 μA at 18 V Over Full Package-Temperature Range: 100 nA at 18 V and 25°C
- Noise Margin (Full Package-Temperature Range):
 - 1 V at $V_{DD} = 5$ V
 - 2 V at $V_{DD} = 10 \text{ V}$
 - 2.5 V at $V_{DD} = 15 \text{ V}$
- Standardized Symmetrical Output Characteristics
- 5-V, 10-V, and 15-V Parametric Ratings

- Meets All Requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"
- Latch-Up Performance Meets 50 mA per JESD 78, Class I

APPLICATIONS

- Parallel Input/Serial Output Data Queuing
- Parallel-to-Serial Data Conversion
- General-Purpose Register



DESCRIPTION

CD4021B series types are 8-stage parallel- or serial-input/serial output registers having common CLOCK and PARALLEL/SERIAL CONTROL inputs, a single SERIAL data input, and individual parallel "JAM" inputs to each register stage. Each register stage is a D-type, master-slave flip-flop. In addition to an output from stage 8, "Q" outputs are also available from stages 6 and 7. Parallel as well as serial entry is made into the register synchronously with the positive clock line transition in the CD4014B. In the CD4021B serial entry is synchronous with the clock but parallel entry is asynchronous. In both types, entry is controlled by the PARALLEL/SERIAL CONTROL input. When the PARALLEL/SERIAL CONTROL input is low, data is serially shifted into the 8-stage register synchronously with the positive transition of the clock line. When the PARALLEL/SERIAL CONTROL input is high, data is jammed into the 8-stage register via the parallel input lines and synchronous with the positive transition of the clock line. In the CD4021B, the CLOCK input of the internal stage is "forced" when asynchronous parallel entry is made. Register expansion using multiple packages is permitted.

The CD4021B series types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic packages (E suffix), and in chip form (H suffix).

ORDERING INFORMATION(1)

T _A	PACK	AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 125°C	SOIC - D	Reel of 2500	CD4010BQDRQ1	CD4021BQ	

- For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI
 web site at www.ti.com.
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



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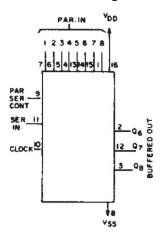




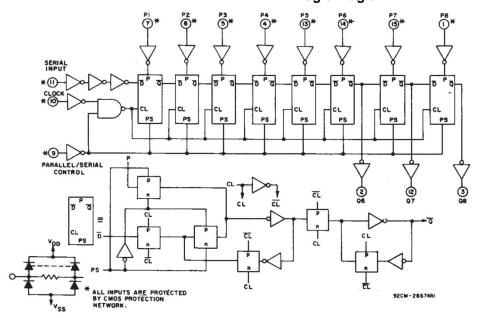
This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

Functional Diagram



Logic Diagram



TRUTH TABLE - CD4021B

CL	Serial Input	Parallel/ Serial Control	Pl-1	Pl-n	Q ₁ (Internal)	an
х	×	1	0	0	0	0
Х	х	1	0	1	0	1
X	X	1	1	0	1	0
х	х	1	1	1	1	1
$\overline{}$	0	0	x	×	0	Q _n ·1
	1	0	x	X	1	Q _n ·1
_	х	0	×	х	Ω1	an

ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			VALUE	UNIT
V_{DD}	DC supply voltage range (voltage	referenced to V _{SS} terminal)	-0.5 to +20	V
	Input voltage range, all inputs		-0.5 to V _{DD} +0.5	V
	DC input current, any one input		±10	mA
		$T_A = -40^{\circ}C \text{ to } +100^{\circ}C$	500	
P _D	Power dissipation per package	$T_A = +100^{\circ}C \text{ to } +125^{\circ}C$	Derate Linearity at 12mW/°C to 20 mW	mW
P_D	Device dissipation per output tran	sistor	100	mW
T _A	Operating temperature range		-40 to +125	°C
T _{stg}	Storage temperature range		-65 to +150	°C
		Human-body model (HBM)	2000	
ESD	Electrostatic discharge rating (2)	Machine model (MM)	200	V
		Charged-Device Model (CDM)	1000	
	Latch-up performance per JESD 7	78, Class I	50	mA

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ Tested in accordance with AEC-Q100.

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RECOMMENDED OPERATING CONDITIONS

At $T_A = 25$ °C, unless other wise specified. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

			V _{DD}	MIN	MAX	UNIT			
	Supply voltage range (T _A = full package-temperature range	e)		3	18	V			
			5	180					
t _W	Clock pulse width		10	80		ns			
			15	50					
			5		3				
f_{CL}	Clock frequency		10		6	MHz			
			15		8.5				
			5		15				
t _r CL, t _f CL	Clock rise and fall time		10		15	μs			
40L			15		15				
			5	120					
		Serial input (referred to CL)	10	80		ns			
			15	60					
	Set-up time		5	80		ns			
		Parallel inputs CD4014B (referred to CL)	10	50					
		OD4014D (referred to OL)	15	40					
ts			5	50					
		Parallel inputs CD4021B (referred to P/S)	10	30		ns			
		OD4021D (referred to 170)	15	20					
			5	180					
		Parallel/Serial Control CD4014B (referred to CL)	10	80		ns			
		OD4014D (referred to OL)	15	60					
			5	160					
t _W	Parallel/serial pulse width		10	80		ns			
			15	50					
			5	280					
t _{REM}	Parallel/serial removal time		10	140		ns			
			15	100					

STATIC ELECTRICAL CHARACTERISTICS

		TEST	CONDIT	IONS	LIM	ITS AT IN	DICATED	TEMPERA	TURES (°C)		
	PARAMETER	V _D	V _{IN}	V_{DD}	40	.05	.405	+25			UNIT	
		(V)	(V)	(V)	-40	+85	+125	5	150	150		
			0.5	5	10	300	300		0.04	5		
I Max	Quiescent device current		0.10	10	20	600	600		0.04	10	μΑ	
I _{DD} Max			0.15	15	100	3000	3000		0.04	20		
			0.20	20	0.61	0.42	0.36		0.08	100		
		0.4	0.5	5	1.5	1.1	0.9	0.51	1			
I _{OL} Min	Output low (sink) current	0.5	0.10	10	4	2.8	2.4	1.3	2.6		i	
		1.5	0.15	15	-0.61	-0.42	-0.36	3.4	6.8			
		4.6	0.5	5	-1.8	-1.3	-1.15	-0.51	-1		mA	
I Min	Output high (source) current	2.5	0.5	5	-1.5	-1.1	-0.9	-1.6	-3.2			
I _{OH} Min		9.5	0.10	10	-4	-2.8	-2.4	-1.3	-2.6			
		13.5	0.15	15	-4.2			-3.4	-6.8			
	Output voltage: low level		0.5	5		0.05			0	0.05		
V _{OL} Max			0.10	10		0.05			0	0.05		
			0.15	15		0.05			0	0.05	\ /	
			0.5	5		4.95		4.95	5		V	
V_{OH} Min	Output voltage: high level		0.10	10		9.95		9.95	10			
			0.15	15		14.95		14.95	15			
		0.5, 4.5		5		1.5				1.5		
V _{IL} Max	Input low voltage	1, 9		10		3				3		
VIL WAX	input low voitage	1.5, 13.5		15		4				4		
V _{IH} Min		0.5, 4.5		5		3.5		3.5			V	
	Input high voltage	1, 9		10		7		7				
	inpat mgm voltage	1.5, 13.5		15		11		11				
I _{IN} Max	Input current		0, 18	18	±0.1	±1	±1		±10 ⁻⁵	±0.1	μΑ	

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DYNAMIC ELECTRICAL CHARACTERISTICS

 $T_A = 25$ °C, Input $t_r/t_f = 20$ ns, $C_L = 50$ pF, $R_L 200$ k Ω

	PARAMETER	TEST CONDITIONS	V_{DD}	MIN	TYP	MAX	UNIT
			5		160	320	
t _{PLH} , t _{PHL}	Propagation delay time		10		80	160	ns
PHL			15		30	120	•
			5		100	200	
t _{THL} , t _{TLH}	Transition time		10		50	100	ns
·ILH			15		40	80	
			5	3	6		
f_{CL}	Maximum clock input ⁽¹⁾		10	6	12		MHz
			15	8.5	17		
			5		90	180	
t _W	Minimum clock pulse width (1)		10		40	80	ns
			15		25	50	
			5			15	
t _r CL, t _f CL	Clock rise and fall time (2)(1)		10			15	μs
402			15			15	•
			5		60	120	
		Serial input (referred to CL)	10		40	80	
			15		30	60	
			5		40	80	
		Parallel inputs (referred to CL)			25	50	1
	Minimum setup time ⁽¹⁾		15		20	40	ne
t _s	Minimum setup time (*)	Parallel inputs (referred to P/S)			25	50	+
					15	30	
					10	20	1
			5		90	180	•
		Serial in, Parallel in, Parallel/Serial Control	10		40	80	
			15		30	60	•
			5			0	
t _H	Minimum hold time ⁽¹⁾		10			0	ns
			15			0	•
			5		80	160	
t_{WH}	Minimum P/S pulse width (1)		10		40	80	ns
			15		25	50	•
			5		140	280	
t _{REM}	Minimum P/S removal time(1)		10		70	140	ns
			15		50	100	
Cı	Average input capacitance ⁽¹⁾				5	7.5	pF

⁽¹⁾ Not production tested

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⁽²⁾ If more than one unit is cascaded, t_rCL should be made less than or equal to the sum of the transition time and the fixed propagation delay of the output of the driving stage for the estimated capacitive load.

Typical Characteristics

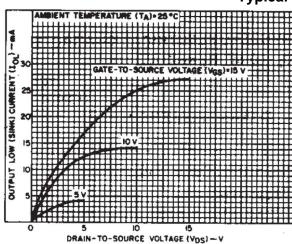


Figure 1. Typical Output Low (Sink) Current Characteristics

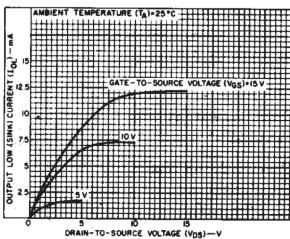


Figure 2. Minimum Output Low (Sink) Current Characteristics

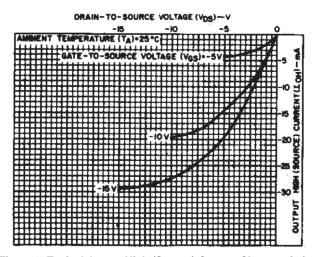


Figure 3. Typical Output High (Source) Current Characteristics

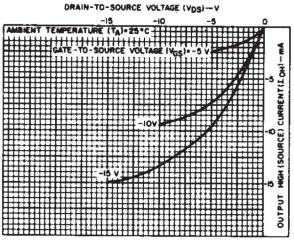


Figure 4. Minimum Output High (Source) Current Characteristics

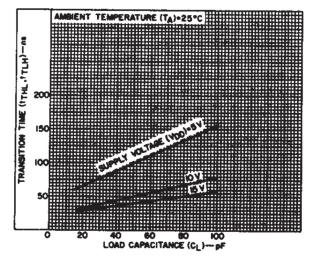


Figure 5. Typical Transition Time as a Function of Load Capacitance

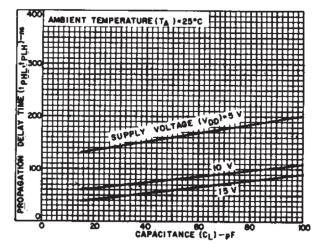


Figure 6. Typical Propagation Delay Times as a Function of Load Capacitance

Typical Characteristics (continued)

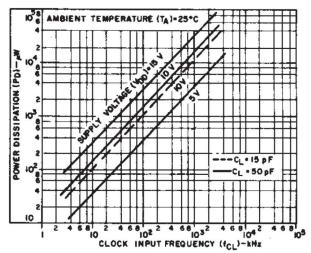


Figure 7. Typical Dynamic Power Dissipation as a Function of Clock Input Frequency

PARAMETER MEASUREMENT INFORMATION

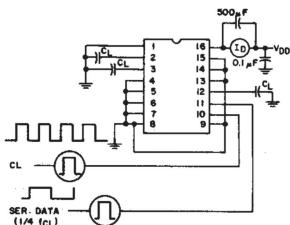


Figure 8. Dynamic Power Dissipation Test Circuit

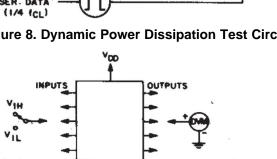


Figure 10. Input Voltage Test Circuit

TEST ANY COMBINATION OF INPUTS

¥ Vss

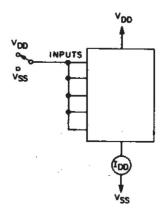


Figure 9. Quiescent Device Current Test Circuit

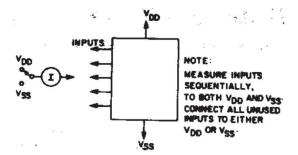
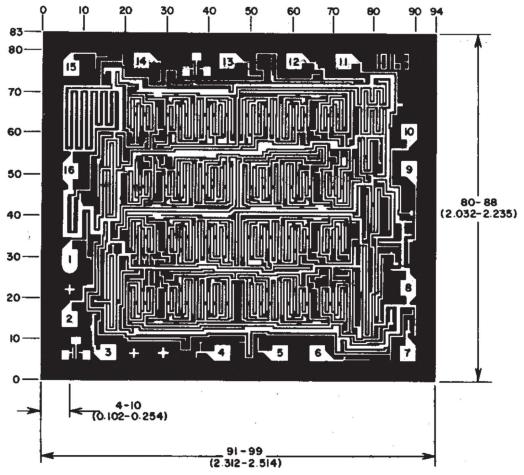


Figure 11. Input Current Test Circuit





Note: Dimensions in parentheses are in millimeters and are dereived from the basic inch dimensions as indicated. Grid graduation are in mils (10^{-3} inch) .

Figure 12. Dimensions and Pad Layout







10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CD4021BQDRQ1	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CD4021BQ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD4021B-Q1:



PACKAGE OPTION ADDENDUM

10-Dec-2020

• Military: CD4021B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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